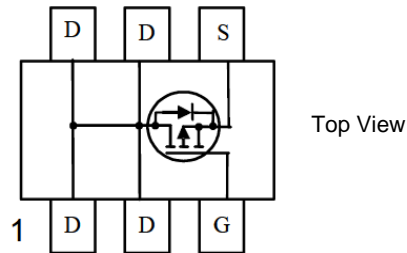


## P-Channel Enhancement Mode Field Effect Transistor

### ● Features

$V_{DS}$	$R_{DS(ON)max}$	$I_D$
-20V	55 mΩ@-10V	-4.8A
	66 mΩ@-4.5V	
	120 mΩ@-2.5V	

### ● Pin Configurations



### ● General Description

The HG5P20MD uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V while retaining a 12V  $V_{GS(MAX)}$  rating.

This device is suitable for use as a uni-directional or bi-directional load switch.

### ● Absolute Maximum Ratings @ $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter		Symbol	Ratings	Unit
Drain-Source Voltage		$V_{DSS}$	20	V
Gate-Source Voltage		$V_{GSS}$	$\pm 12$	V
Drain Current (Continuous) *AC	$T_C=25^\circ\text{C}$	$I_D$	-4.8	A
	$T_C=70^\circ\text{C}$		-4	
Drain Current (Pulse) *B		$I_{DM}$	-20	A
Power Dissipation	$T_C=25^\circ\text{C}$	$P_D$	1.25	W
Operating Temperature/ Storage Temperature		$T_J/T_{STG}$	-55~150	$^\circ\text{C}$

### ● Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-ambient	$R_{thj-amb}$	65	$^\circ\text{C}/\text{W}$

## Electrical Characteristics

$T_A=25^{\circ}\text{C}$  unless otherwise noted

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-20	--	--	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -20V, V_{GS} = 0V$	--	--	-1	$\mu A$
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_{DS} = -250\mu A$	-0.7	-1	-1.3	V
Gate Leakage Current	$I_{GSS}$	$V_{GS} = \pm 12V, V_{DS} = 0V$	--	--	100	nA
Drain-Source On-state Resistance	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -4.2A$	--	--	55	m $\Omega$
		$V_{GS} = -4.5V, I_D = -4A$	--	--	66	m $\Omega$
		$V_{GS} = -2.5V, I_D = -1A$	--	--	120	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = -5V, I_D = -2A$	--	9	--	S
Diode Forward Voltage	$V_{SD}$	$I_{SD} = -1A, V_{GS} = 0V$	--	-0.78	-1	V
Reverse Recovery Time	$t_{rr}$	$I_S = -4A, V_{GS} = 0V,$	--	25	--	ns
Reverse Recovery Charge	$Q_{rr}$	$dI/dt = 100A/\mu s$	--	17	--	nC
<b>Switching</b>						
Total Gate Charge	$Q_g$	$V_{GS} = -4.5V, V_{DS} = -10V, I_D = -4A$	--	11.3	--	nC
Gate-Source Charge	$Q_{gs}$		--	1.7	--	nC
Gate-Drain Charge	$Q_{gd}$		--	4.2	--	nC
Turn-on Delay Time	$t_{d(on)}$	$V_{DS} = -10V, I_D = -4A,$ $V_{GS} = -10V, R_G = 6\Omega$	--	6.5	--	ns
Turn-on Rise Time	$t_r$		--	3.5	--	ns
Turn-off Delay Time	$t_{d(off)}$		--	40	--	ns
Turn-off Fall Time	$t_f$		--	13	--	ns
<b>Dynamic</b>						
Input Capacitance	$C_{iss}$	$V_{DS} = -10V, V_{GS} = 0V, f = 1.0MHz$	--	675	--	pF
Output Capacitance	$C_{oss}$		--	85	--	pF
Reverse Transfer Capacitance	$C_{rss}$		--	62	--	pF

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C: The current rating is based on the  $t \leq 10s$  junction to ambient thermal resistance rating.

# Typical Electrical and Thermal Characteristics

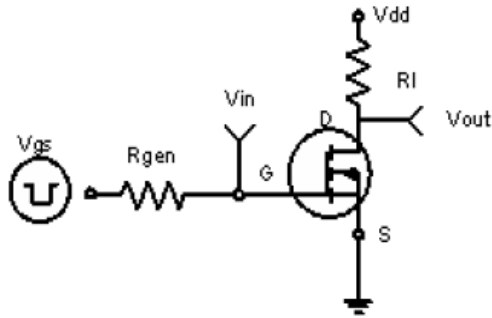


Figure 1: Switching Test Circuit

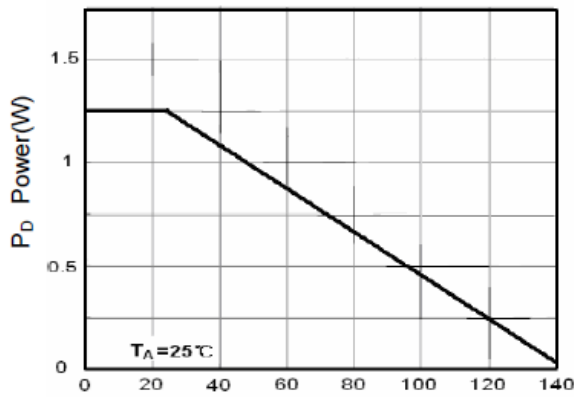


Figure 3 Power Dissipation

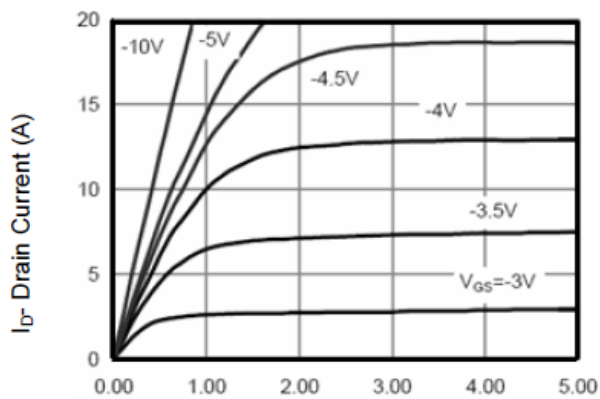


Figure 5 Output Characteristics

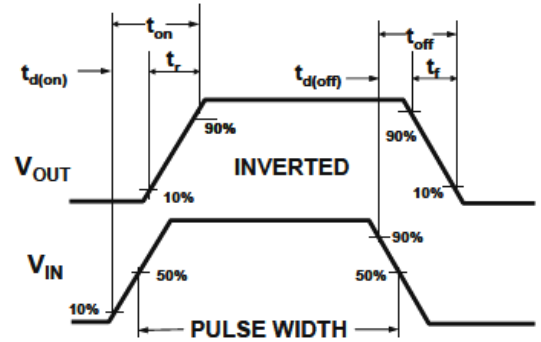


Figure 2: Switching Waveforms

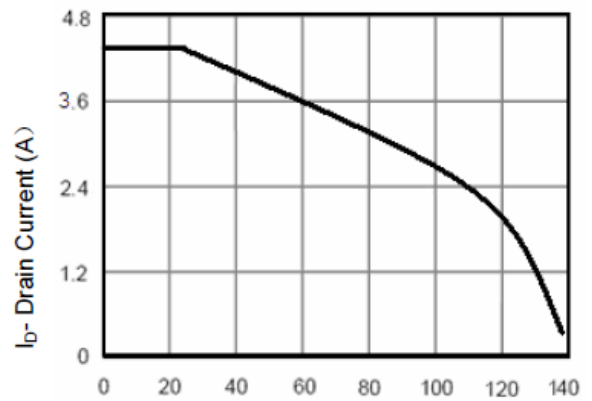


Figure 4 Drain Current

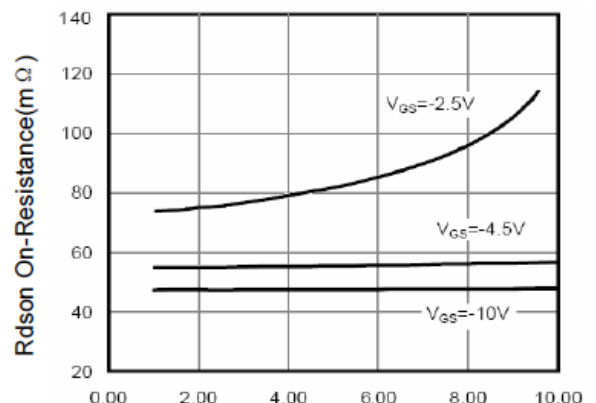


Figure 6 Drain-Source On-Resistance

# Typical Electrical and Thermal Characteristics

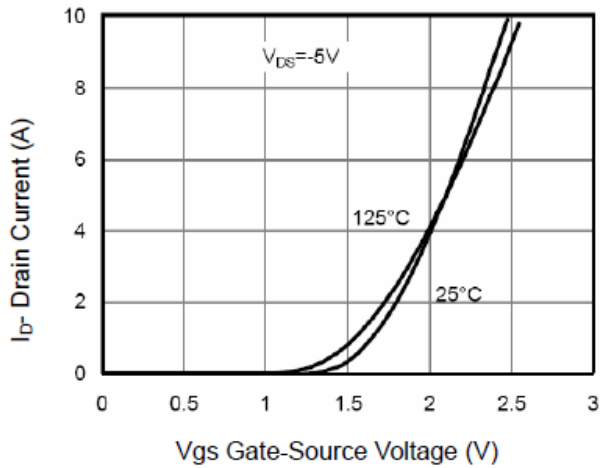


Figure 7 Transfer Characteristics

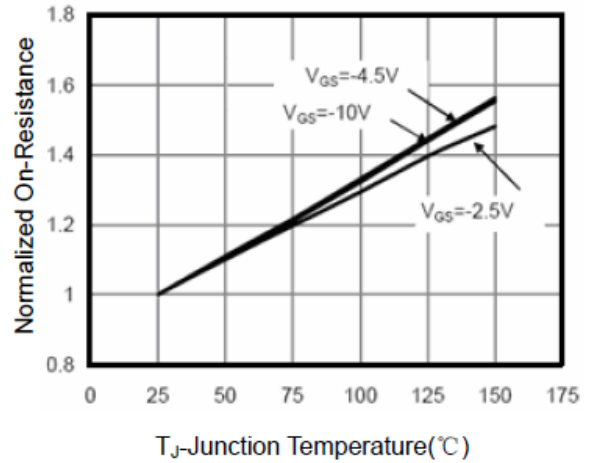


Figure 8 Drain-Source On-Resistance

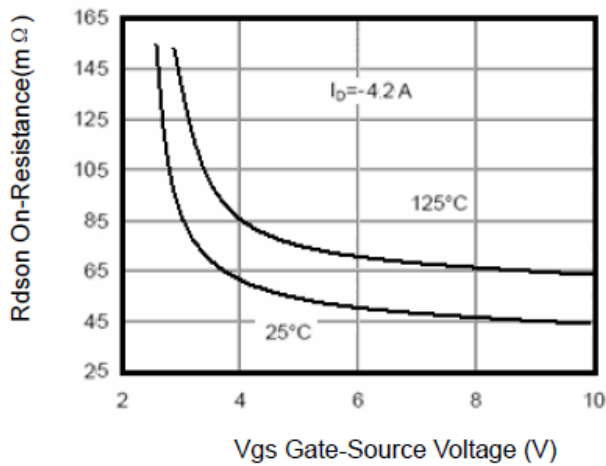


Figure 9 Rdson vs Vgs

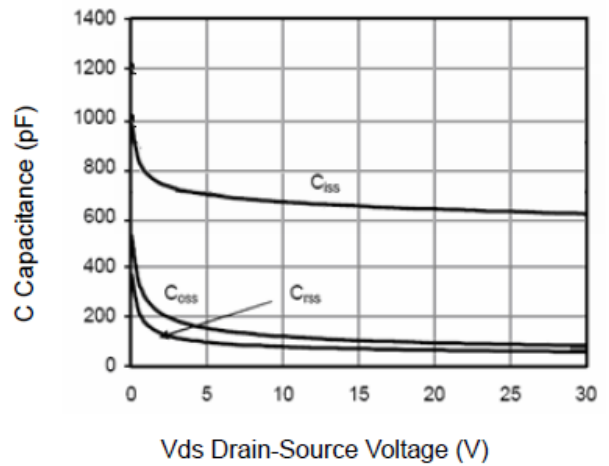


Figure 10 Capacitance vs Vds

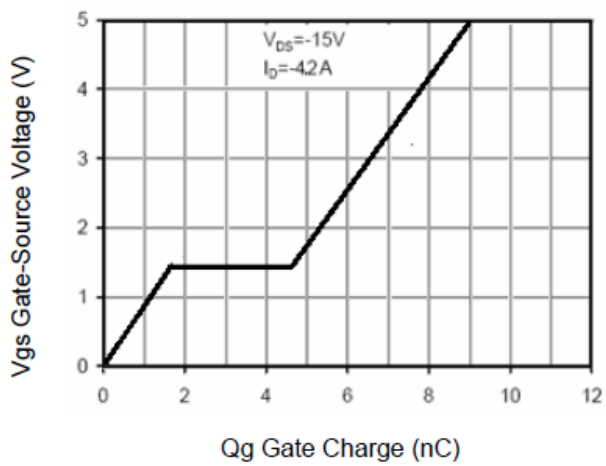


Figure 11 Gate Charge

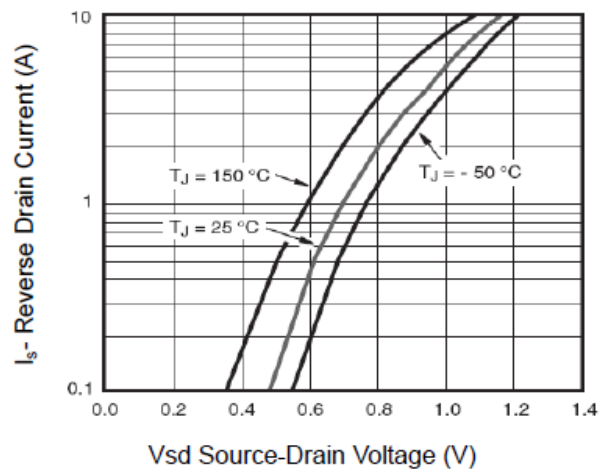


Figure 12 Source- Drain Diode Forward

# Typical Electrical and Thermal Characteristics

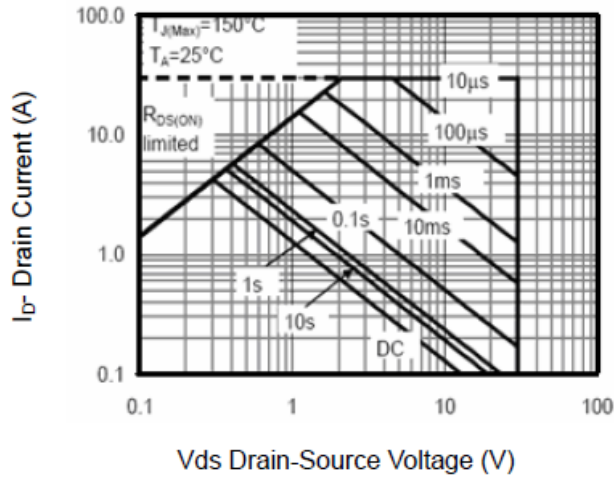


Figure 13 Safe Operation Area

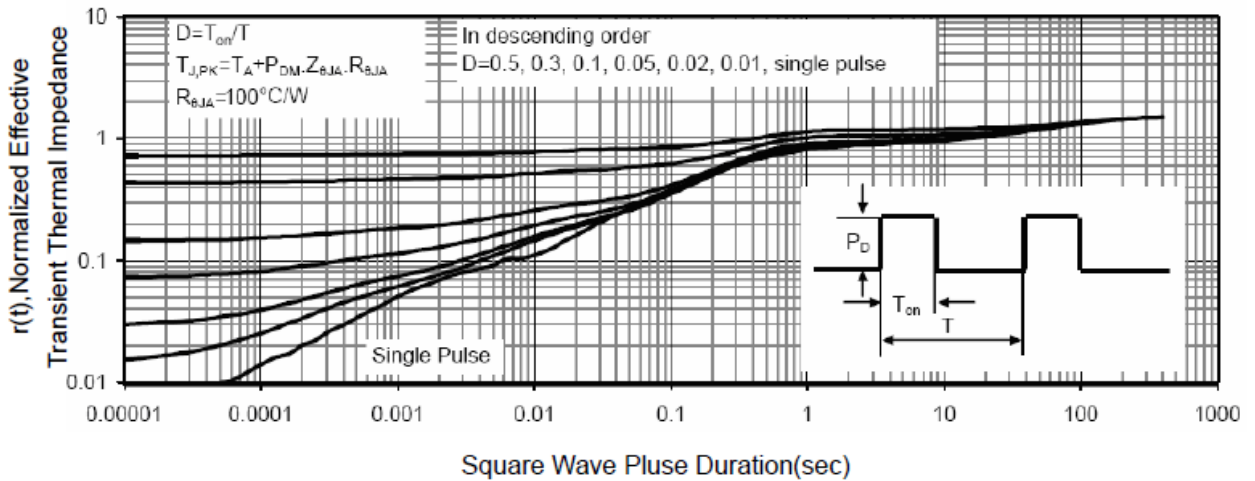


Figure 14 Normalized Maximum Transient Thermal Impedance

# Package Information

